

Certificate



Registration No.: PV 60028981

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Report No.: 15035653.009

License Holder:

Sunrise Solartech Co., Ltd.
No. 65-22 Xinggang Rd,
Zhonglou Development Zone, Changzhou,
Jiangsu 213023
P. R. China

Manufacturing plant:

Sunrise Solartech Co., Ltd.
No. 65-22 Xinggang Rd,
Zhonglou Development Zone, Changzhou,
Jiangsu 213023
P. R. China

Product:

PV Module

Type:

SR-M572xxx (xxx=160-195 in steps of 5)
SR-M672xxx (xxx=255-310 in steps of 5)
SR-M660xxx (xxx=215-260 in steps of 5)
SR-M654xxx (xxx=205-225 in steps of 5)
SR-M648xxx (xxx=180-200 in steps of 5)
SR-P672xxx (xxx=245-295 in steps of 5)
SR-P666xxx (xxx=225-270 in steps of 5)
SR-P660xxx (xxx=205-245 in steps of 5)
SR-P654xxx (xxx=185-220 in steps of 5)
SR-P648xxx (xxx=165-195 in steps of 5)
with black backsheet:

SR-M572xxx-B (xxx=160-195 in steps of 5)
SR-M672xxx-B (xxx=255-310 in steps of 5)
SR-M660xxx-B (xxx=215-260 in steps of 5)
SR-M654xxx-B (xxx=205-225 in steps of 5)
SR-M648xxx-B (xxx=180-200 in steps of 5)
SR-P672xxx-B (xxx=245-295 in steps of 5)
SR-P666xxx-B (xxx=225-270 in steps of 5)
SR-P660xxx-B (xxx=205-245 in steps of 5)
SR-P654xxx-B (xxx=185-220 in steps of 5)
SR-P648xxx-B (xxx=165-195 in steps of 5)

Basis:



**IEC 61215:2005
EN 61215:2005**

"Crystalline silicon terrestrial
photovoltaic (PV) modules - Design
qualification and type approval"



Factory Inspection

To document the consistent quality of
the product factory inspections are
performed periodically.



- Qualified, IEC 61215
- Periodic Inspection

Remarks:

- The details of the factory inspection are documented in report no.15035809.004.
- Modification to encapsulation system, superstrate and black backsheet and extension to higher power output.

Conditions:

The product test is voluntarily according to technical regulations. Any change of the design, materials, components or processing may require the repetition of some of the qualification tests in order to retain type approval.

The certificate is valid until 23 February 2015.



Cologne, 16 May 2012

Dipl.-Ing. M. Adrian